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	10603746	CHANG, JEOM-JIN
	Examiner	Art Unit
	Wyszynski, Aubrey H	2134

Wyszynski, Aubrey H (Assistant Examiner)	12/5/07 (Date)	<i>AKW</i>	<i>Gilberto Barron Jr</i> GILBERTO BARRON JR SUPERVISORY PATENT EXAMINER Kambiz Zand TECHNOLOGY CENTER/2900 (Primary Examiner)	Total Claims Allowed: 14	
<i>K. Harris 12/17/07</i> (Legal Instruments Examiner)	(Date)		(Date) <i>12/19/07</i>	O.G. Print Claim(s) 1	O.G. Print Figure 1